# POLYMERS DIVISION

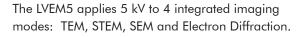
## Measurement Facilities: Nanocharacterization

The Polymers Division has established several capabilities for structural measurements of polymer and organic thin films and nanoparticles. These include the ability to map out surface features at the nano-scale and associated kinetic and thermodynamic changes of nanostructure with temperature and magnetic field.

#### Atomic Force Microscopy (AFM)

A set of three AFM's that range from "workhorse" to multi-modal high throughput instruments are available in this facility. Specifically:

- Small sample, AFM for quick measurements of sample surface morphology
- Large sample AFM with a high precision closed loop scanner and a large travel stage for automated measurements over large areas such as a combinatorial gradient.
- Small sample AFM with high precision closed loop scanner and a variety of sample environments including fluid operation, variable humidity and temperature. Functionalities include a heated tip for measuring local thermomechanical properties of polymers, electrical measurements for measuring potential across organic electronic devices, and magnetic field measurements for examining magnetic nanoparticles.





LVEM for low resolution electron microscopy needs

#### Surface Plasmon Resonance (SPR) with Fluorescence Imaging Microscopy

This state-of-art temperature controlled SPR-Fluorescence imaging instrument is developed to map multiple nanoparticle-biomolecule (proteins, lipids, enzyme) interactions by the use of immobilized nanoparticles that are pre-patterned on gold and silver coated substrates. Interactions with different biomolecules can be simultaneously measured by changes in the SPR and TIR-fluorescence signal. Changes associated to biomolecule binding can be related directly to the underlying nanoparticle pat-terning characteristics. The results can be analyzed by Langmuir adsorption isotherms for determination of the binding energies of nanoparticlebiomolecule associations.





Multifunctional high-precision AFM.

### Low Voltage Electron Microscopy (LVEM)

The LVEM5 is a very simple desktop design and has practically no installations demands:

- Due to the low accelerating voltage, no staining is required. The result is high contrast imaging of polymer samples in their native states



Surface plasmon resonance with fluorescence microscopy for mapping nanoparticle interactions with biomolecules.

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